

EE C247B - ME C218 Introduction to MEMS Design Spring 2017

Prof. Clark T.-C. Nguyen

Dept. of Electrical Engineering & Computer Sciences
University of California at Berkeley
Berkeley, CA 94720

Lecture Module 7: Mechanics of Materials

EE C245: Introduction to MEMS Design

LecM 7

C. Nguyei

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Outline

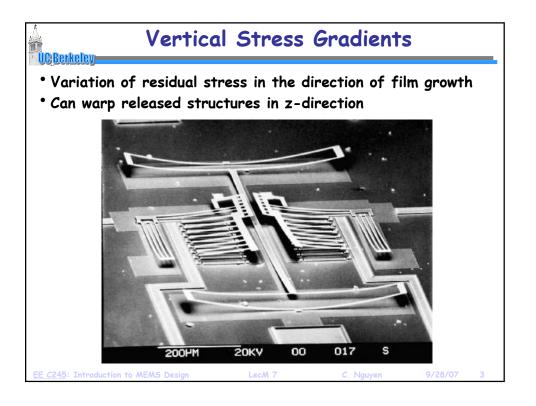
- Reading: Senturia, Chpt. 8
- Lecture Topics:
 - \$Stress, strain, etc., for isotropic materials
 - Thin films: thermal stress, residual stress, and stress gradients
 - **♥Internal dissipation**
 - **MEMS** material properties and performance metrics

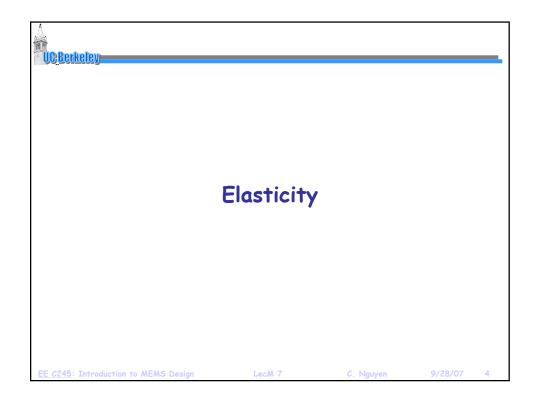
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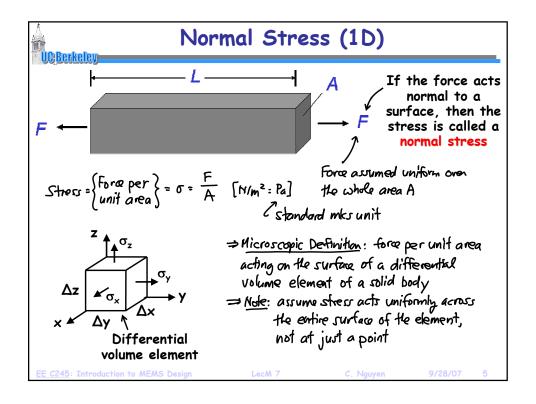
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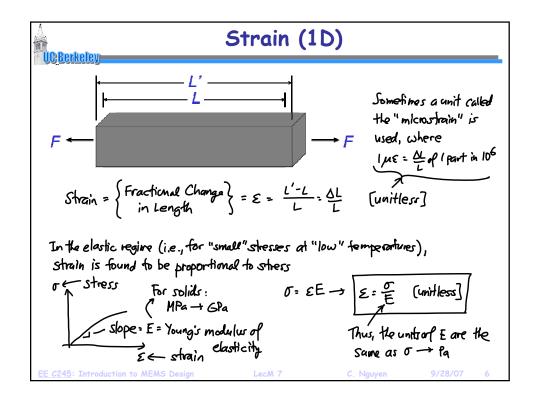
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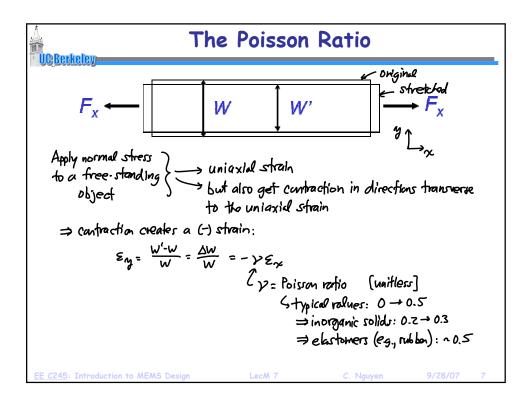
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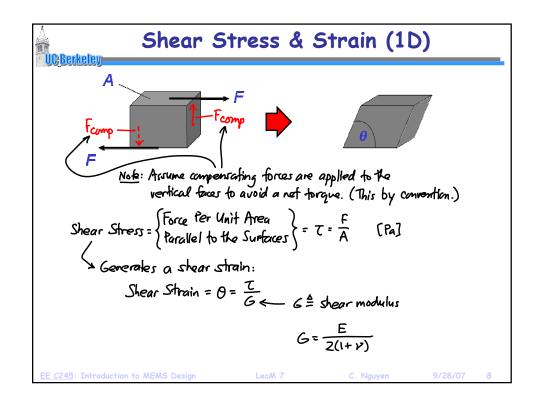


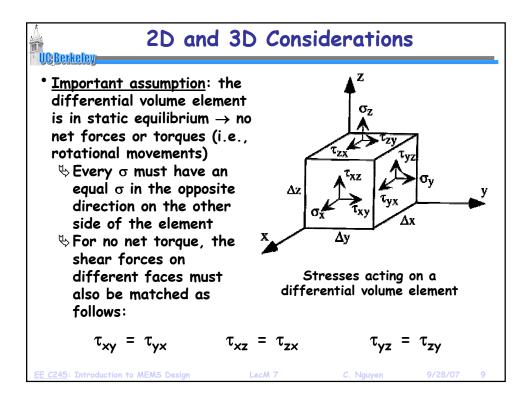


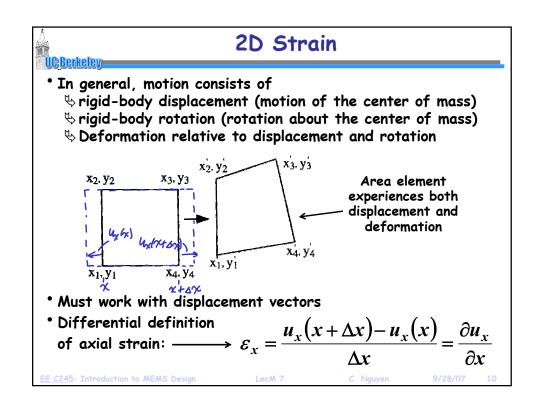


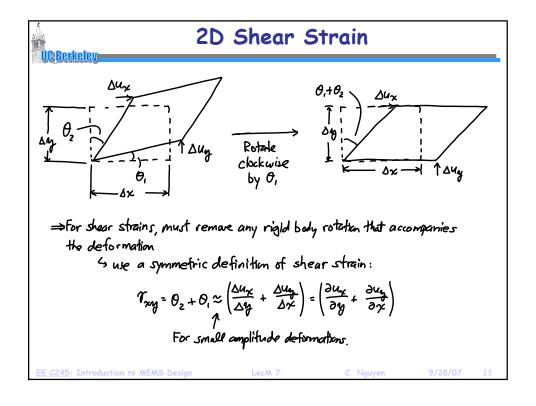


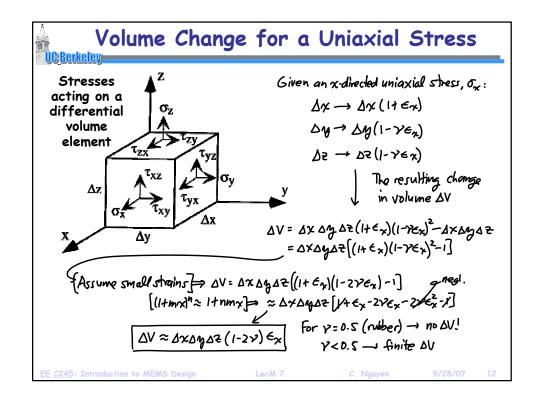












Isotropic Elasticity in 3D

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- Isotropic = same in all directions
- The complete stress-strain relations for an isotropic elastic solid in 3D: (i.e., a generalized Hooke's Law)

$$\varepsilon_{x} = \frac{1}{E} \left[\sigma_{x} - \nu \left(\sigma_{y} + \sigma_{z} \right) \right] \qquad \gamma_{xy} = \frac{1}{G} \tau_{xy}$$

$$\varepsilon_{y} = \frac{1}{E} \left[\sigma_{y} - \nu \left(\sigma_{z} + \sigma_{x} \right) \right] \qquad \gamma_{yz} = \frac{1}{G} \tau_{yz}$$

$$\varepsilon_z = \frac{1}{E} \left[\sigma_z - \nu \left(\sigma_x + \sigma_y \right) \right] \qquad \gamma_{zx} = \frac{1}{G} \tau_{zx}$$

Basically, add in off-axis strains from normal stresses in other directions

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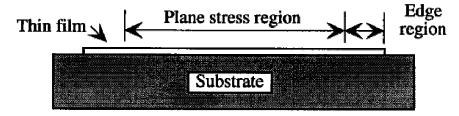
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Important Case: Plane Stress

 <u>Common case</u>: very thin film coating a thin, relatively rigid substrate (e.g., a silicon wafer)



- * At regions more than 3 thicknesses from edges, the top surface is stress-free $\to \sigma_z$ = 0
- Get two components of in-plane stress:

$$\varepsilon_x = (1/E)[\sigma_x - v(\sigma_y + 0)]$$

$$\varepsilon_{v} = (1/E)[\sigma_{v} - \nu(\sigma_{x} + 0)]$$

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Important Case: Plane Stress (cont.)

- Symmetry in the xy-plane $\rightarrow \sigma_x = \sigma_y = \sigma$
- * Thus, the in-plane strain components are: ϵ_x = ϵ_y = ϵ where

$$\varepsilon_x = (1/E)[\sigma - v\sigma] = \frac{\sigma}{[E/(1-v)]} = \frac{\sigma}{E'}$$

and where

Biaxial Modulus
$$\stackrel{\triangle}{=} E' = \frac{E}{1-\nu}$$

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Edge Region of a Tensile (σ >0) Film **UC Berkeley** Net non-zero in-At free edge, Film must plane force (that in-plane force be bent we just analyzed) must be zero; back, here Shear stresses There's no Poisson $F \neq 0$ contraction, so the film is slightly thicker, here Extra peel force Discontinuity of stress Peel forces that at the attached corner can peel the film → stress concentration · off the surface

Linear Thermal Expansion

- As temperature increases, most solids expand in volume
- Definition: linear thermal expansion coefficient

Linear thermal expansion coefficient
$$\triangleq \alpha_T = \frac{d\varepsilon_x}{dT}$$
 [Kelvin⁻¹]

Remarks:

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- * α_{T} values tend to be in the 10^{-6} to 10^{-7} range
- $^{\bullet}$ Can capture the 10^{-6} by using dimensions of $\mu strain/K$, where 10^{-6} K^{-1} = 1 $\mu strain/K$
- In 3D, get volume thermal expansion coefficient $\longrightarrow \frac{\Delta V}{V} = 3\alpha_T \Delta T$
- For moderate temperature excursions, α_{T} can be treated as a constant of the material, but in actuality, it is a function of temperature

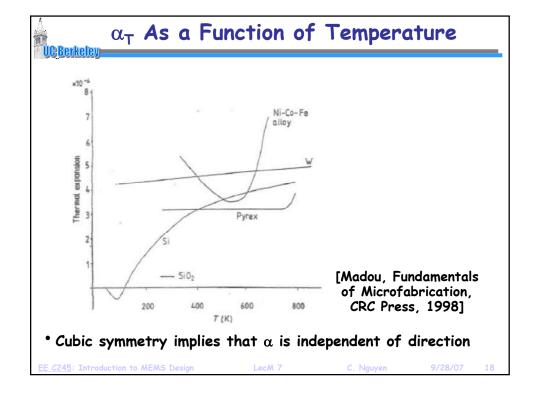
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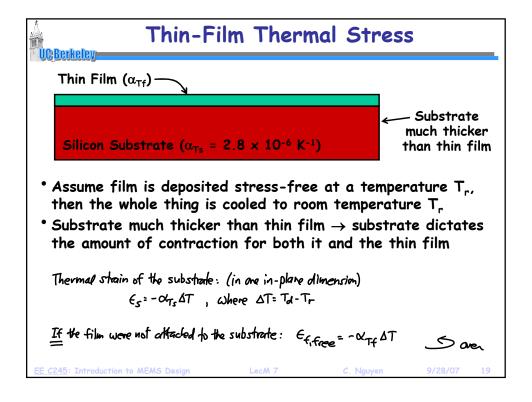
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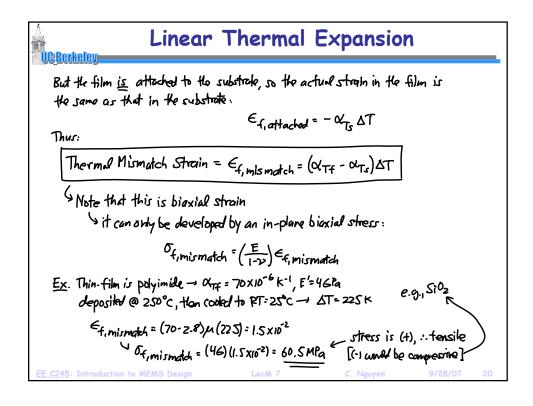
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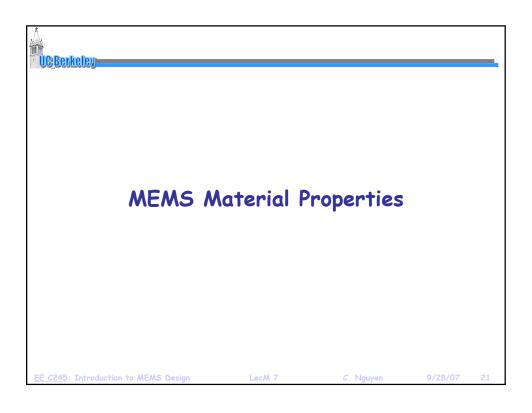
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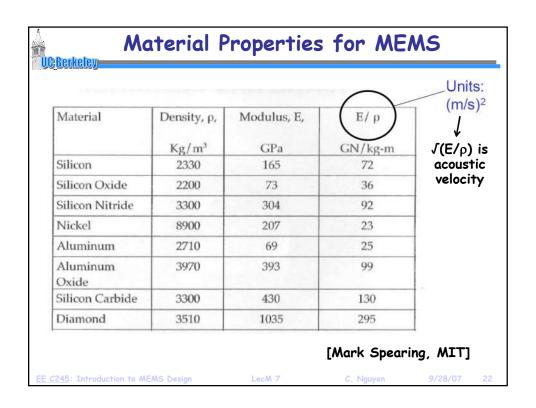
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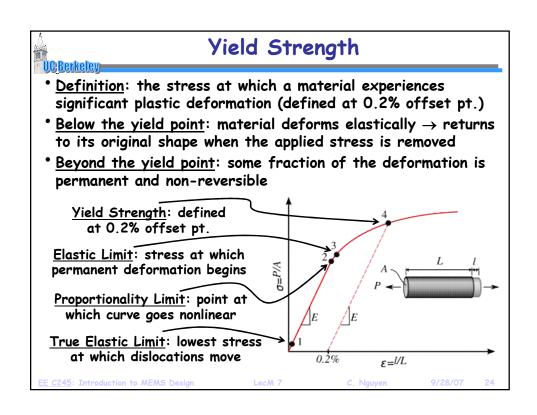


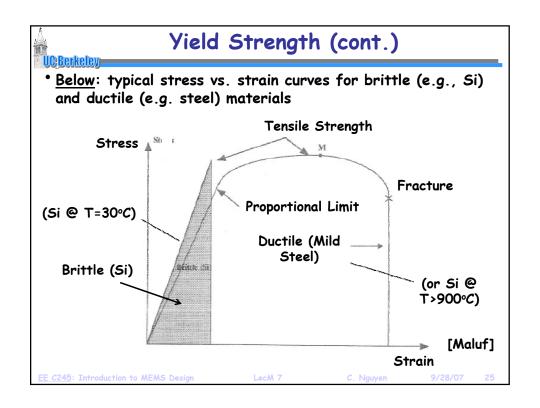


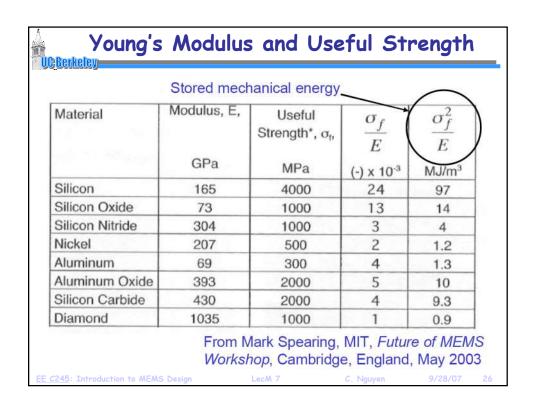


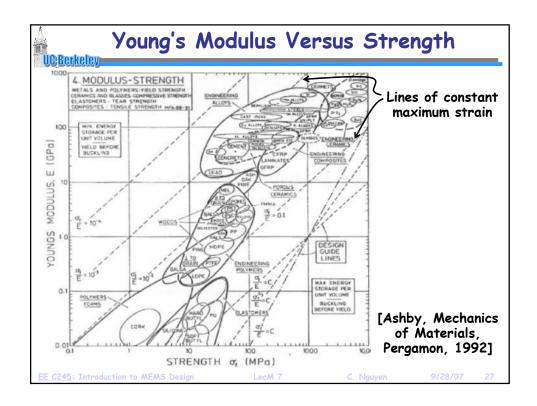


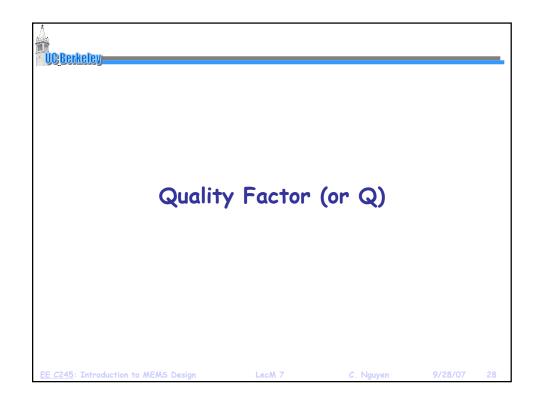


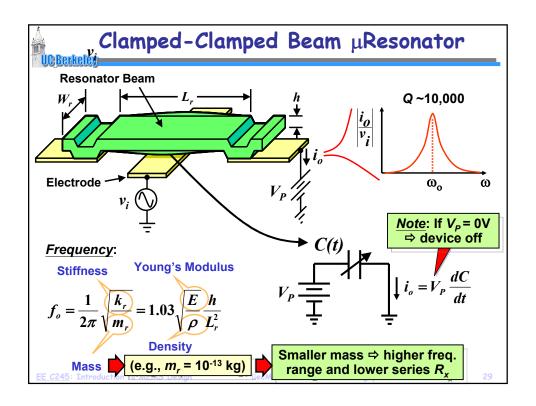


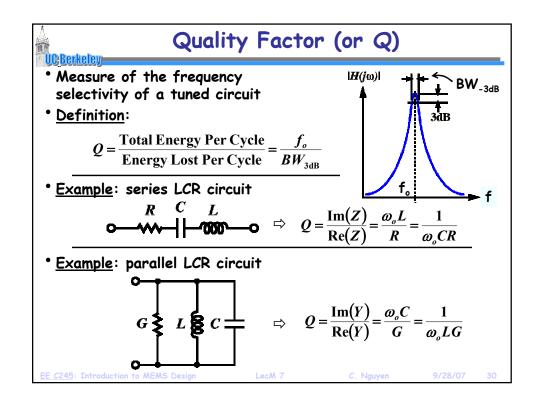


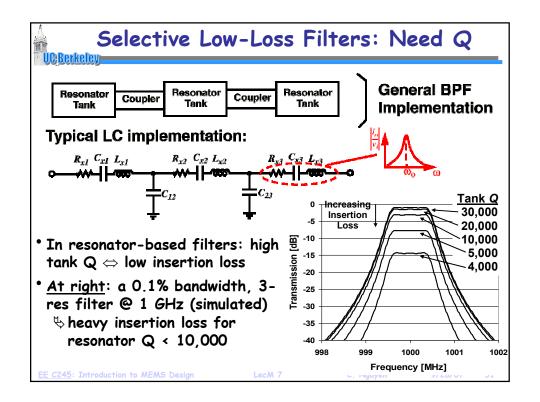


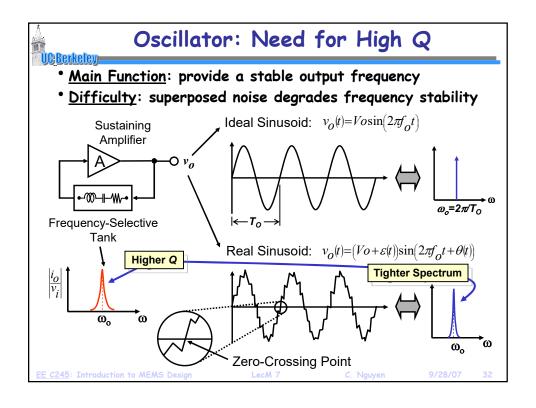


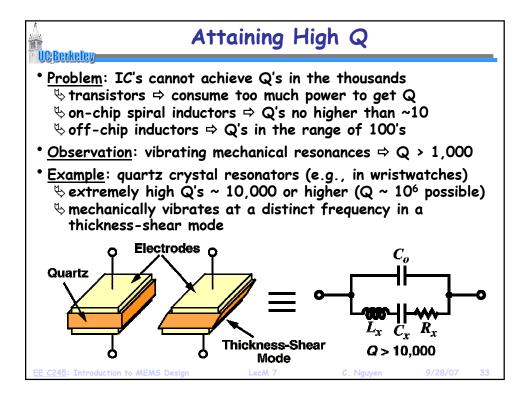


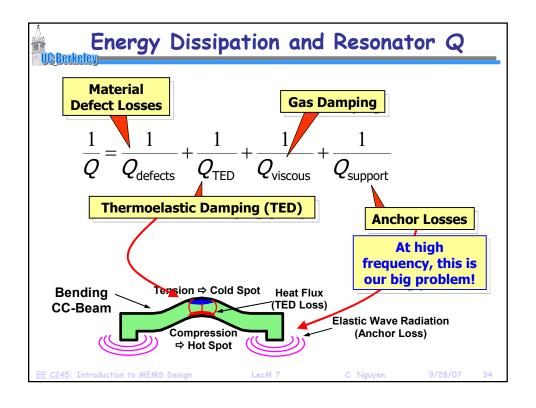


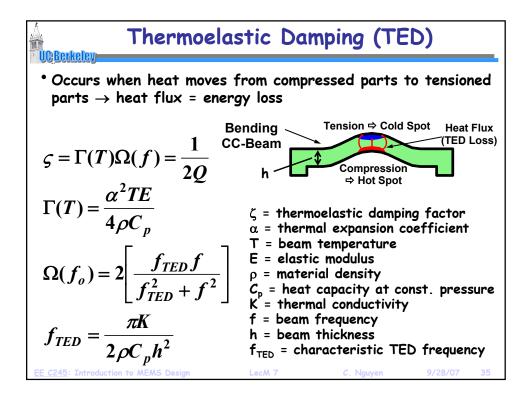


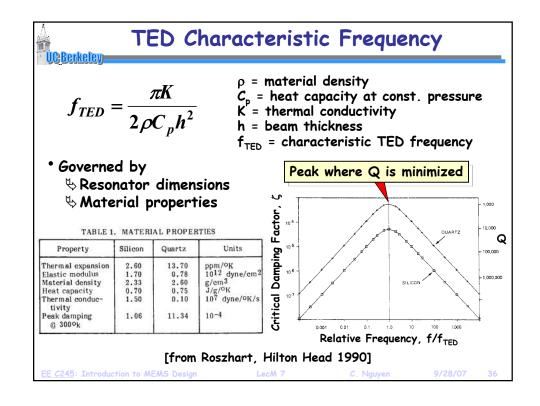


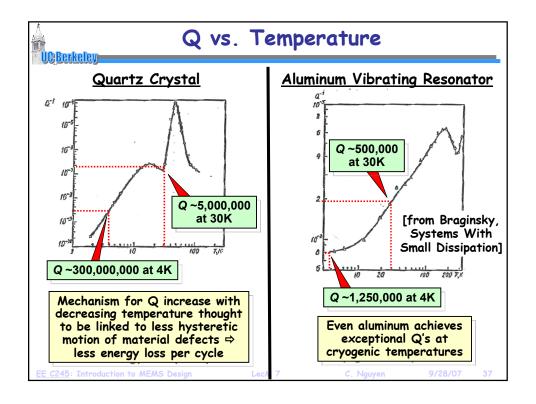


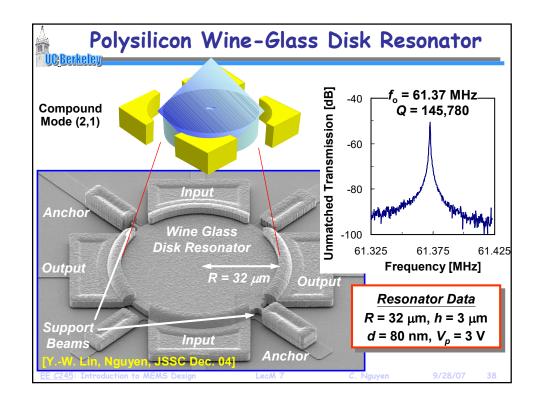




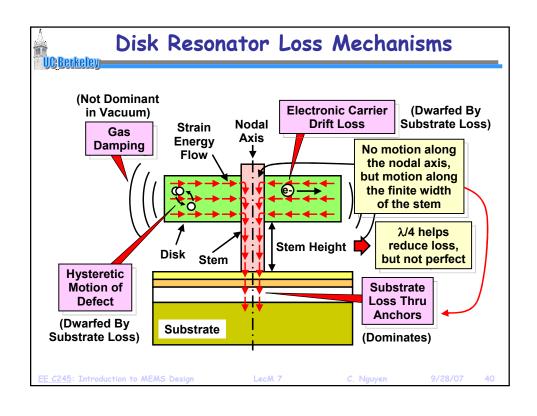


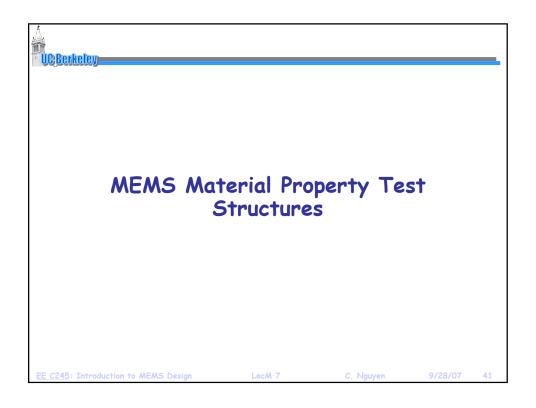


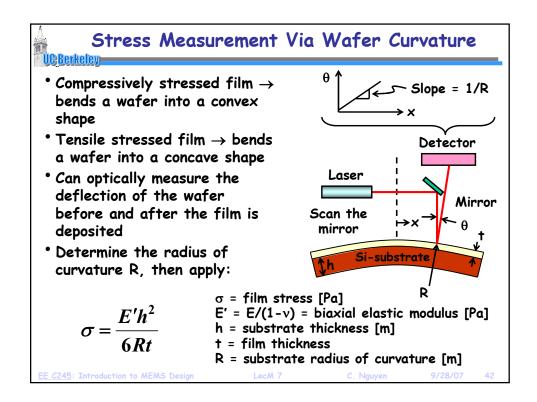


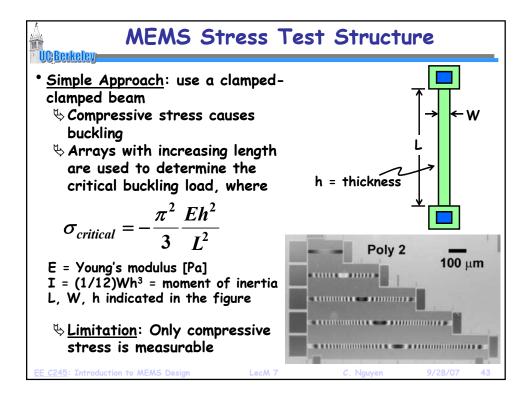


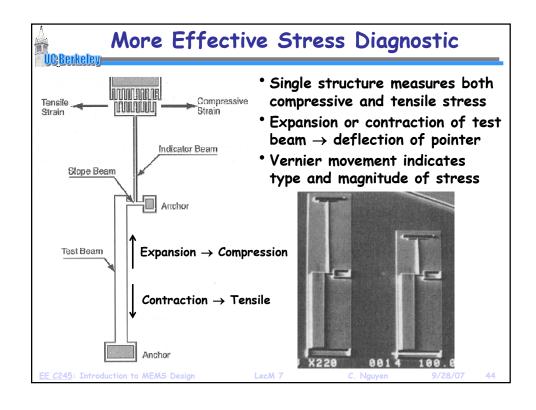
1.51-GHz, Q=11,555 Nanocrystalline Diamond Disk uMechanical Resonator -• Impedance-mismatched stem for reduced anchor dissipation Operated in the 2nd radial-contour mode • Q ~11,555 (vacuum); Q ~10,100 (منه) Design/Performance: • Below: 20 µm diameter disk $R=10\mu m$, $t=2.2\mu m$, d=800Å, $V_P=7$ V f_o=1.51 GHz (2nd mode), Q=11,555 -84 $f_o = 1.51 \text{ GHz}$ -86 Q = 11,555 (vac)-88 **Amplitude** Q = 10,100 (air)-90 Polysilicon 0 (air) -92 Electrode -94 -96 Mixed -98 -100 **CVD Diamond** 1507.4 1507.6 1507.8 1508 սMechanical Disk Ground Frequency [MHz] Plane [Wang, Butler, Nguyen MEMS'04]

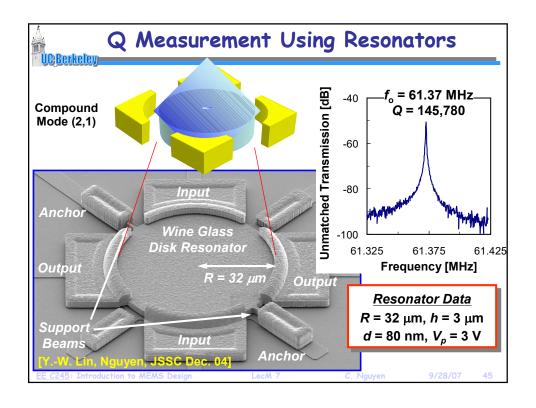


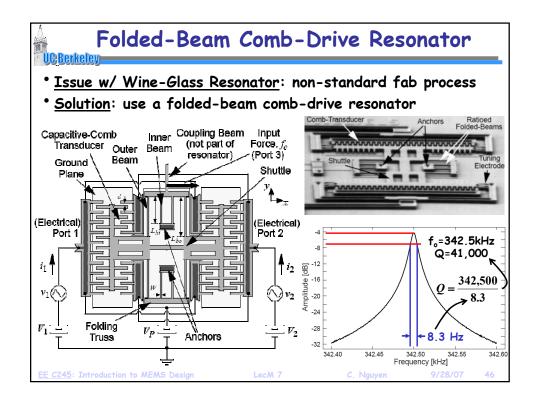


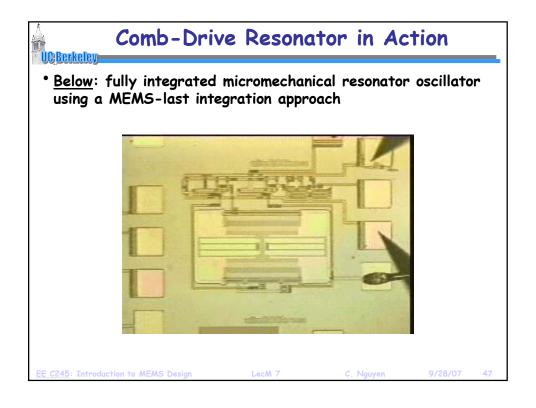


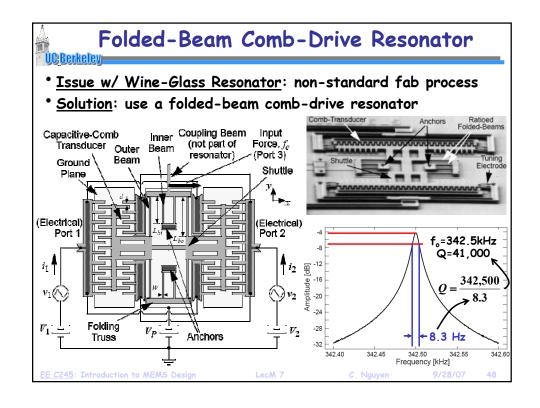


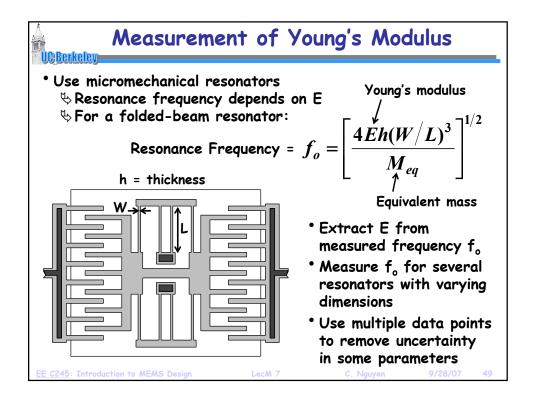


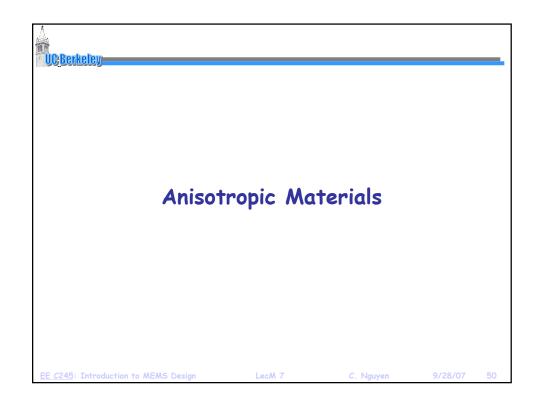












Elastic Constants in Crystalline Materials

- * Get different elastic constants in different crystallographic directions \rightarrow 81 of them in all
 - © Cubic symmetries make 60 of these terms zero, leaving 21 of them remaining that need be accounted for
- Thus, describe stress-strain relations using a 6x6 matrix

$$\begin{bmatrix} \sigma_x \\ \sigma_y \\ \sigma_z \\ \tau_{yz} \\ \tau_{zx} \\ \tau_{xy} \end{bmatrix} = \begin{bmatrix} C_{11} & C_{12} & C_{13} & C_{14} & C_{15} & C_{16} \\ C_{12} & C_{22} & C_{23} & C_{24} & C_{25} & C_{26} \\ C_{13} & C_{23} & C_{33} & C_{34} & C_{35} & C_{36} \\ C_{14} & C_{24} & C_{34} & C_{44} & C_{45} & C_{46} \\ C_{15} & C_{25} & C_{35} & C_{45} & C_{55} & C_{56} \\ C_{16} & C_{26} & C_{36} & C_{46} & C_{56} & C_{66} \end{bmatrix} \begin{bmatrix} \varepsilon_x \\ \varepsilon_y \\ \varepsilon_z \\ \gamma_{yz} \\ \gamma_{zx} \\ \gamma_{xy} \end{bmatrix}$$
Stresses

Stiffness Coefficients

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Stiffness Coefficients of Silicon

- Due to symmetry, only a few of the 21 coefficients are non-zero
- With cubic symmetry, silicon has only 3 independent components, and its stiffness matrix can be written as:

$$\begin{bmatrix} \sigma_x \\ \sigma_y \\ \sigma_z \\ \tau_{yz} \\ \tau_{zx} \\ \tau_{xy} \end{bmatrix} = \begin{bmatrix} C_{11} & C_{12} & C_{13} & 0 & 0 & 0 \\ C_{12} & C_{22} & C_{23} & 0 & 0 & 0 \\ C_{13} & C_{23} & C_{33} & 0 & 0 & 0 \\ 0 & 0 & 0 & C_{44} & 0 & 0 \\ 0 & 0 & 0 & 0 & C_{55} & 0 \\ 0 & 0 & 0 & 0 & 0 & C_{66} \end{bmatrix} \begin{bmatrix} \varepsilon_x \\ \varepsilon_y \\ \varepsilon_z \\ \gamma_{yz} \\ \gamma_{zx} \\ \gamma_{xy} \end{bmatrix}$$

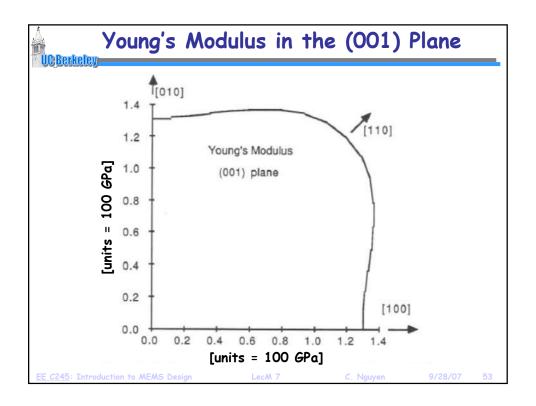
where
$$\left\{ \begin{array}{l} \textit{C}_{11} = 165.7 \; \textit{GPa} \\ \textit{C}_{12} = 63.9 \; \textit{GPa} \\ \textit{C}_{44} = 79.6 \; \textit{GPa} \end{array} \right.$$

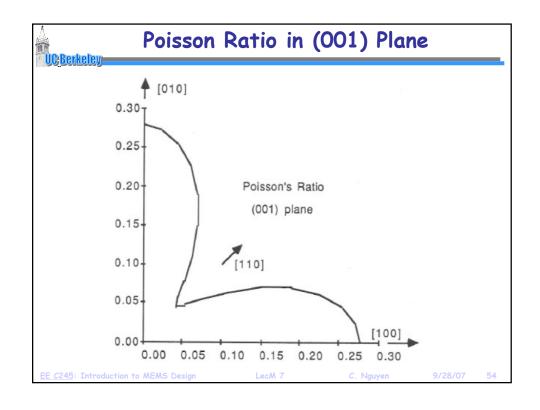
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Anisotropic Design Implications UC Berkeley Young's modulus and Poisson ratio variations in anisotropic materials can pose problems in the design of certain structures • E.g., disk or ring resonators, which rely on isotropic properties in the radial directions Wine-Glass ♦ Okay to ignore variation in RF Mode Disk resonators, although some Q hit is probably being taken * E.g., ring vibratory rate gyroscopes 🌣 Modė matching is required,

be the same

where frequencies along different axes of a ring must

Not okay to ignore anisotropic

Ring Gyroscope